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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of
JAHROMI et al

Serial No. 10/578,265

Filed: July 3, 2006



Atty. Ref.: 4662-182

TC/A.U.: Unassigned

Examiner: Unassigned

For: A METHOD AND APPARATUS FOR PRODUCING MICROCHIPS

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July 26, 2006

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

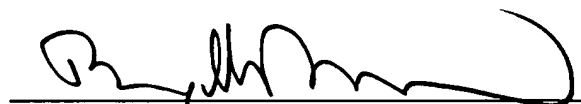
As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO/SB/08a, a copy of each non-U.S. reference is enclosed. This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited.

The Examiner is requested to initial the attached form PTO/SB/08a and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

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INFORMATION DISCLOSURE CITATION

ATTY. DOCKET NO.

4662-182

APPLICANT

JAHROMI et al

SERIAL NO.

10/578.265



(Use several sheets if necessary)

FILING DATE

July 3, 2006

TC/A.U.

Unassigned

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

PATENT DOCUMENT							TRANSLATION	
DOCUMENT			DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
		10340846	12/22/1998	JAPAN				
		627,719	08/15/1949	GB				
		2005/006026 A2	01/20/2005	PCT				
		1 522 894 A2	04/13/2005	EP				
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		00/06495	02/10/2000	PCT				
		0 967 513 A1	12/29/1999	EP				

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

	European Search Report
	International Search Report
	M ROTHSCCHILD et al; "Fluorine – an enable in advanced photolithography"; Journal of Fluorine Chemistry; vol. 122; no. 1; July 1 2003; pages 3-10

*Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.